

# MOSFET – Power, Single N-Channel

60 V, 50 A, 9.3 m $\Omega$ 

# NTTFS5CS73NL

#### **Features**

- Small Footprint (3.3x3.3 mm) for Compact Design
- Low R<sub>DS(on)</sub> to Minimize Conduction Losses
- Low Q<sub>G</sub> and Capacitance to Minimize Driver Losses
- These Devices are Pb–Free, Halogen Free/BFR Free and are RoHS Compliant

# MAXIMUM RATINGS (T<sub>J</sub> = 25°C unless otherwise noted)

Symbol	Parar	Value	Unit			
V <sub>DSS</sub>	Drain-to-Source Voltage			60	V	
V <sub>GS</sub>	Gate-to-Source Voltage	Э		±20	V	
I <sub>D</sub>	Continuous Drain		T <sub>C</sub> = 25°C	50	Α	
	Current R <sub>0JC</sub> (Notes 1, 3)	Steady	T <sub>C</sub> = 100°C	35	W	
P <sub>D</sub>	Power Dissipation	State	T <sub>C</sub> = 25°C	46		
	R <sub>θJC</sub> (Note 1)		T <sub>C</sub> = 100°C	23		
I <sub>D</sub>	Continuous Drain		T <sub>A</sub> = 25°C	13	Α	
	Current R <sub>0JA</sub> (Notes 1, 2, 3)	Steady	T <sub>A</sub> = 100°C	9		
P <sub>D</sub>	Power Dissipation					
	R <sub>θJA</sub> (Notes 1 & 2)		T <sub>A</sub> = 100°C	1.6		
I <sub>DM</sub>	Pulsed Drain Current	in Current $T_A = 25^{\circ}C$ , $t_p = 10 \mu s$			Α	
T <sub>J</sub> , T <sub>stg</sub>	Operating Junction and Storage Temperature			-55 to +175	°C	
I <sub>S</sub>	Source Current (Body Diode)			52	Α	
E <sub>AS</sub>	Single Pulse Drain-to-Source Avalanche Energy (I <sub>L(pk)</sub> = 2.3 A)			88	mJ	
TL	Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			260	°C	

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

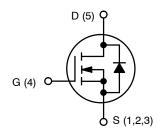
#### THERMAL RESISTANCE MAXIMUM RATINGS

Symbol	Parameter	Value	Unit
$R_{\theta JC}$	Junction-to-Case - Steady State	3.2	°C/W
$R_{\theta JA}$	Junction-to-Ambient - Steady State (Note 2)	48	

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm<sup>2</sup>, 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

V <sub>(BR)DSS</sub>	R <sub>DS(ON)</sub> MAX	I <sub>D</sub> MAX
60 V	9.3 m $\Omega$ @ 10 V	50 A
00 V	13.3 m $\Omega$ @ 4.5 V	50 A

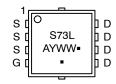
#### **N-CHANNEL MOSFET**



# **MARKING DIAGRAM**



WDFN8 (μ8FL) CASE 511AB



S73L = Specific Device Code A = Assembly Location

Y = Year WW = Work Week ■ = Pb-Free Package

(Note: Microdot may be in either location)

#### **ORDERING INFORMATION**

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

NOTE: Some of the devices on this data sheet have been **DISCONTINUED**. Please refer to the table on page 5.

# **ELECTRICAL CHARACTERISTICS** ( $T_J = 25^{\circ}C$ unless otherwise specified)

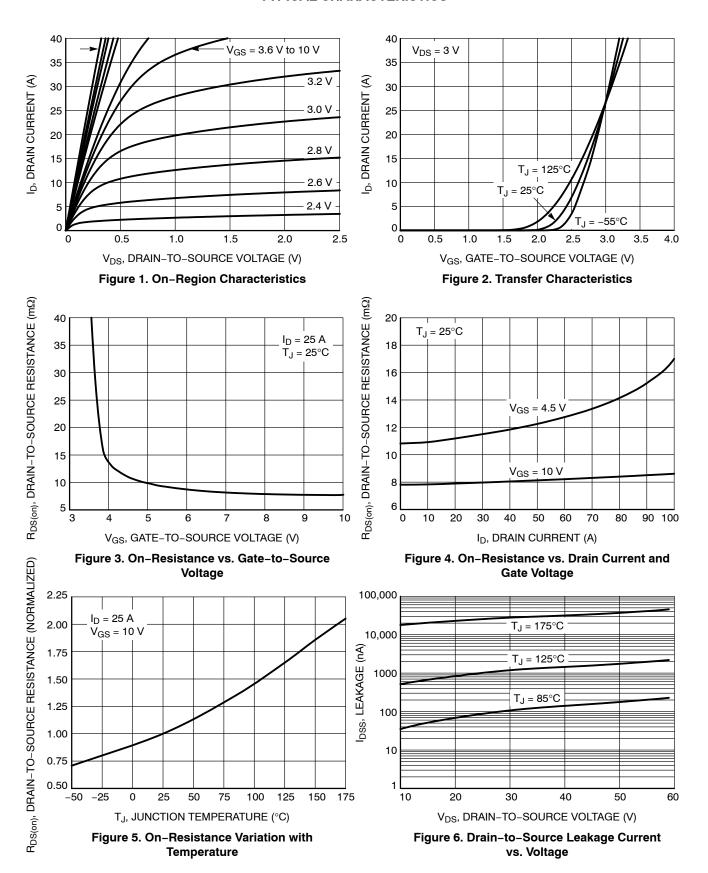
Symbol	Parameter	Test Cond	Test Condition		Тур	Max	Unit
OFF CHAR	ACTERISTICS	•			•	•	
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	V <sub>GS</sub> = 0 V, I <sub>D</sub> :	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$				V
V <sub>(BR)DSS</sub> /	Drain-to-Source Breakdown Voltage Temperature Coefficient				28		mV/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C			10	_
		V <sub>DS</sub> = 60 V	T <sub>J</sub> = 125°C			250	μΑ
I <sub>GSS</sub>	Gate-to-Source Leakage Current	V <sub>DS</sub> = 0 V, V <sub>G</sub>	<sub>S</sub> = 20 V			100	nA
ON CHARA	CTERISTICS (Note 4)						-
V <sub>GS(TH)</sub>	Gate Threshold Voltage	V <sub>GS</sub> = V <sub>DS</sub> , I <sub>D</sub>	) = 35 μΑ	1.2		2.0	V
V <sub>GS(TH)</sub> /T <sub>J</sub>	Threshold Temperature Coefficient				-4.5		mV/°C
R <sub>DS(on)</sub>	Drain-to-Source On Resistance	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 25 A		8.0	9.3	
		V <sub>GS</sub> = 4.5 V	I <sub>D</sub> = 25 A		11	13.3	mΩ
9FS	Forward Transconductance	V <sub>DS</sub> =15 V, I <sub>I</sub>	V <sub>DS</sub> =15 V, I <sub>D</sub> = 25 A		37		S
CHARGES	AND CAPACITANCES	•			•	•	
C <sub>ISS</sub>	Input Capacitance				880		
C <sub>OSS</sub>	Output Capacitance	V <sub>GS</sub> = 0 V, f = 1 MH		450		pF	
C <sub>RSS</sub>	Reverse Transfer Capacitance			11			
Q <sub>G(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 4.5 V, V <sub>DS</sub> =		4.5		nC	
Q <sub>G(TOT)</sub>	Total Gate Charge	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 3	V <sub>GS</sub> = 10 V, V <sub>DS</sub> = 30 V; I <sub>D</sub> = 25 A				nC
Q <sub>G(TH)</sub>	Threshold Gate Charge						
Q <sub>GS</sub>	Gate-to-Source Charge				2.0		nC
$Q_{GD}$	Gate-to-Drain Charge	$V_{GS} = 4.5 \text{ V}, V_{DS} = 30 \text{ V}; I_D = 25 \text{ A}$			0.8		1
$V_{GP}$	Plateau Voltage				2.9		V
SWITCHING	CHARACTERISTICS (Note 5)					•	•
t <sub>d(ON)</sub>	Turn-On Delay Time				9.0		
t <sub>r</sub>	Rise Time	V <sub>GS</sub> = 4.5 V, V <sub>I</sub>	ne = 30 V.		50		1
t <sub>d(OFF)</sub>	Turn-Off Delay Time	I <sub>D</sub> = 25 A, R <sub>G</sub>	$I_D = 25 \text{ A}, R_G = 2.5 \Omega$		13		ns
t <sub>f</sub>	Fall Time			3.0			
DRAIN-SOL	JRCE DIODE CHARACTERISTICS	•			•	•	
$V_{SD}$	Forward Diode Voltage	V <sub>GS</sub> = 0 V,	T <sub>J</sub> = 25°C		0.9	1.2	
		I <sub>S</sub> = 25 A	$I_{S} = 25 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$		0.8		\ \
t <sub>RR</sub>	Reverse Recovery Time				28		
ta	Charge Time	V <sub>GS</sub> = 0 V, dls/dt	V <sub>GS</sub> = 0 V, dls/dt = 100 A/μs,		14		ns
t <sub>b</sub>	Discharge Time	I <sub>S</sub> = 25 A			14		1
Q <sub>RR</sub>	Reverse Recovery Charge				18		nC

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width  $\leq 300~\mu s$ , duty cycle  $\leq 2\%$ .

5. Switching characteristics are independent of operating junction temperatures.

#### **TYPICAL CHARACTERISTICS**



#### TYPICAL CHARACTERISTICS (continued)

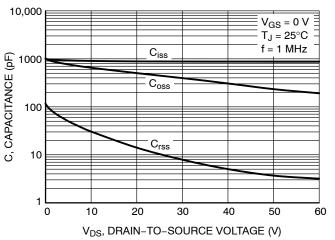


Figure 7. Capacitance Variation

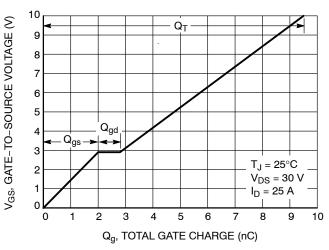


Figure 8. Gate-to-Source vs. Total Charge

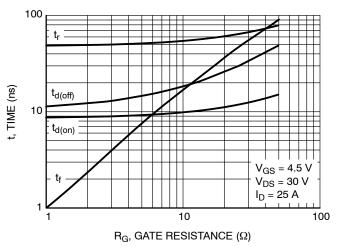


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

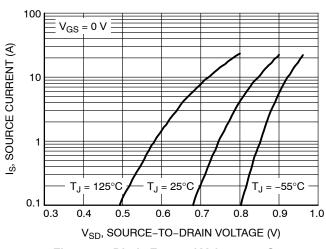


Figure 10. Diode Forward Voltage vs. Current

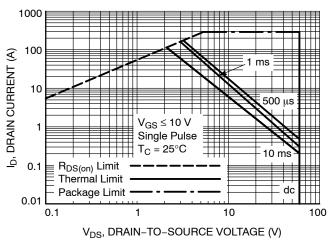


Figure 11. Maximum Rated Forward Biased Safe Operating Area

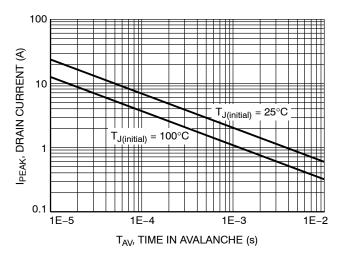


Figure 12. Maximum Drain Current vs. Time in Avalanche

# TYPICAL CHARACTERISTICS (continued)

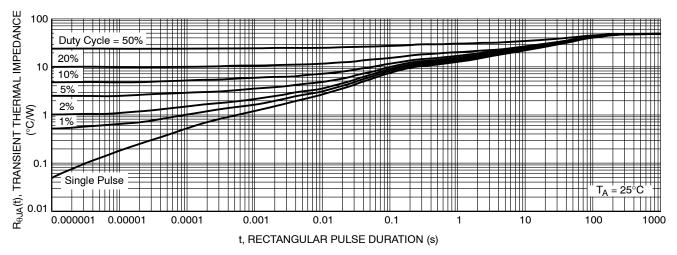


Figure 13. Thermal Response

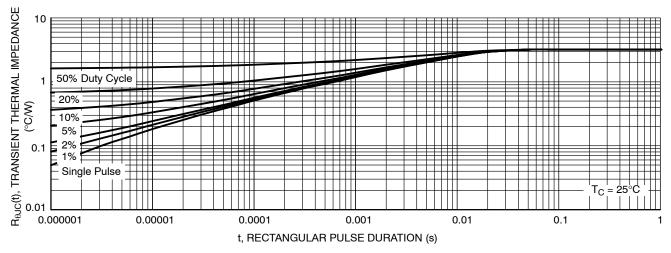


Figure 14. Thermal Response

# **DEVICE ORDERING INFORMATION**

Device	Marking	Package	Shipping <sup>†</sup>
NTTFS5CS73NLTAG	S73L	DFN5 (Pb-Free)	1500 / Tape & Reel

#### **DISCONTINUED** (Note 6)

NTTFS5CS73NLTWG	S73L	DFN5	5000 / Tape & Reel
		(Pb-Free)	

<sup>†</sup>For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, <a href="https://example.com/BRD8011/D">BRD8011/D</a>.

<sup>6.</sup> **DISCONTINUED:** This device is not recommended for new design. Please contact your **onsemi** representative for information. The most current information on this device may be available on <a href="https://www.onsemi.com">www.onsemi.com</a>.







SCALE 2:1

#### WDFN8 3.3x3.3, 0.65P CASE 511AB ISSUE D

**DATE 23 APR 2012** 



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  CONTROLLING DIMENSION: MILLIMETERS.
  DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH
  PROTRUSIONS OR GATE BURRS.

	MILLIMETERS				INCHES	
DIM	MIN	NOM	MAX	MIN	NOM	MAX
Α	0.70	0.75	0.80	0.028	0.030	0.031
A1	0.00		0.05	0.000		0.002
b	0.23	0.30	0.40	0.009	0.012	0.016
С	0.15	0.20	0.25	0.006	0.008	0.010
D		3.30 BSC		0	.130 BSC	;
D1	2.95	3.05	3.15	0.116	0.120	0.124
D2	1.98	2.11	2.24	0.078	0.083	0.088
E	3.30 BSC			0.130 BSC		
E1	2.95	3.05	3.15	0.116	0.120	0.124
E2	1.47	1.60	1.73	0.058	0.063	0.068
E3	0.23	0.30	0.40	0.009	0.012	0.016
е	0.65 BSC			0.026 BSC		
G	0.30	0.41	0.51	0.012	0.016	0.020
K	0.65	0.80	0.95	0.026	0.032	0.037
L	0.30	0.43	0.56	0.012	0.017	0.022
L1	0.06	0.13	0.20	0.002	0.005	0.008
М	1.40	1.50	1.60	0.055	0.059	0.063
θ	0 °		12 °	0 °		12 °



#### **GENERIC MARKING DIAGRAM\***



XXXXX = Specific Device Code Α = Assembly Location

= Year WW = Work Week = Pb-Free Package



DIMENSION: MILLIMETERS

\*For additional information on our Pb-Free strategy and soldering details, please download the onsemi Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	WDFN8 3.3X3.3, 0.65P		PAGE 1 OF 1		

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<sup>\*</sup>This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "■", may or may not be present. Some products may not follow the Generic Marking.

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